## Notice of References Cited

Application/Control No. Applicant(s)/Patent Under Reexamination 10/550,741 SURDEANU ET AL. Examiner Art Unit Page 1 of 1 JOHN LIN 2815

U.S. PATENT DOCUMENTS							
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
*	Α	US-6,667,525	12-2003	Rhee et al.	257/407		
*	В	US-2001/0039107	11-2001	Suguro, Kyoichi	438/585		
*	υ	US-6,399,515	06-2002	Tao et al.	438/734		
*	D	US-6,222,251	04-2001	Holloway, Thomas C.	257/607		
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	F	US-					
	Ø	US-					
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	7	US-					
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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